Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/565,537	MELKONIAN ET AL.	
Examiner	Art Unit	
Taeyoon Kim	1651	

	SEARCHED				
Class	Subclass	Date	Examiner		
	,				
*					

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	1	i	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
·	DATE	EXMR
EAST search (USPG-pub;USPAT;USOCR;EPO;JPO;Derwe nt)	4/26/2007	тк
Inventor search (PALM)	4/27/2007	тк
updated search	10/18/2007	тк